

Search Notes

Application/Control No.

10/042,165

Examiner

Mark A. Mais

Applicant(s)/Patent under
Reexamination

LIN ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	230 235 242	9/18/2006	MAM
	245 252		
	351-355		
	357 392		
	400 401		
	404 419		
	420 437		
	447 448		
	450 451		
	453 455		
	462 464		
	465 508		
	516 517		
	519 528		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See Attached electronic Search	9/18/2006	MAM